



### **HighSpeed 2-Technology**

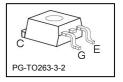
- Designed for frequency inverters for washing machines, fans, pumps and vacuum cleaners
- 2<sup>nd</sup> generation HighSpeed-Technology for 1200V applications offers:
  - loss reduction in resonant circuits
  - temperature stable behavior
  - parallel switching capability
  - tight parameter distribution
  - $E_{off}$  optimized for  $I_{\rm C}$  =3A
- Qualified according to JEDEC<sup>2</sup> for target applications Pb-free lead plating; RoHS compliant
- Complete product spectrum and PSpice Models : http://www.infineon.com/igbt/ •

Туре	V <sub>CE</sub>	<i>I</i> c	$\pmb{E}_{off}$	Tj	Marking	Package
IGB03N120H2	1200V	3A	0.15mJ	150°C	G03H1202	PG-TO263-3-2

### **Maximum Ratings**

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V <sub>CE</sub>	1200	V
Triangular collector current	I <sub>C</sub>		А
$T_{\rm C}$ = 25°C, f = 140kHz		9.6	
<i>T</i> <sub>C</sub> = 100°C, <i>f</i> = 140kHz		3.9	
Pulsed collector current, $t_p$ limited by $T_{jmax}$	I <sub>Cpuls</sub>	9.9	
Turn off safe operating area	-	9.9	
$V_{CE} \le 1200 V, \ T_j \le 150^{\circ} C$			
Gate-emitter voltage	V <sub>GE</sub>	±20	V
Power dissipation	P <sub>tot</sub>	62.5	W
$T_{\rm C}$ = 25°C			
Operating junction and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-40+150	°C
Soldering temperature (reflow soldering, MSL1)	-	245	





<sup>2</sup> J-STD-020 and JESD-022



### **Thermal Resistance**

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic	· · ·			·
IGBT thermal resistance,	R <sub>thJC</sub>		2.0	K/W
junction – case				
Thermal resistance,	R <sub>thJA</sub>		40	
junction – ambient <sup>1)</sup>				

### **Electrical Characteristic,** at $T_j$ = 25 °C, unless otherwise specified

Paramotor	Symbol	Conditions	Value			Unit
Parameter	Symbol	Conditions		Тур.	max.	Unit
Static Characteristic		·				
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{\rm GE}$ =0V, $I_{\rm C}$ =300 $\mu$ A	1200	-	-	V
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	$V_{\rm GE}$ = 15V, $I_{\rm C}$ =3A				
		<i>T</i> <sub>j</sub> =25°C	-	2.2	2.8	
		<i>T</i> <sub>i</sub> =150°C	-	2.5	-	
		$V_{\rm GE} = 10 V, I_{\rm C} = 3 A,$				
		<i>T</i> <sub>j</sub> =25°C	-	2.4	-	
Gate-emitter threshold voltage	$V_{\text{GE(th)}}$	$I_{\rm C}$ =90 $\mu$ A, $V_{\rm CE}$ = $V_{\rm GE}$	2.1	3	3.9	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V, V <sub>GE</sub> =0V				μA
		<i>T</i> <sub>j</sub> =25°C	-	-	20	
		<i>T</i> <sub>j</sub> =150°C	-	-	80	
Gate-emitter leakage current	I <sub>GES</sub>	$V_{CE}=0V, V_{GE}=20V$	-	-	100	nA
Transconductance	<b>g</b> <sub>fs</sub>	V <sub>CE</sub> =20V, <i>I</i> <sub>C</sub> =3A	-	2	-	S
Dynamic Characteristic						
Input capacitance	Ciss	V <sub>CE</sub> =25V,	-	205	-	pF
Output capacitance	Coss	V <sub>GE</sub> =0V,	-	24	-	
Reverse transfer capacitance	Crss	f=1MHz	-	7	-	
Gate charge	Q <sub>Gate</sub>	V <sub>CC</sub> =960V, <i>I</i> <sub>C</sub> =3A	-	22	-	nC
		V <sub>GE</sub> =15V				
Internal emitter inductance	LE		-	7	-	nH
measured 5mm (0.197 in.) from case						

 $^{1)}$  Device on 50mm\*50mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70µm thick) copper area for collector connection. PCB is vertical without blown air.



### Switching Characteristic, Inductive Load, at Ti=25 °C

Parameter	Symbol	Conditions	Value			11
Parameter	Symbol	Symbol Conditions		typ.	max.	Unit
IGBT Characteristic	•					
Turn-on delay time	t <sub>d(on)</sub>	<i>T</i> <sub>j</sub> =25°C,	-	9.2	-	ns
Rise time	t <sub>r</sub>	$V_{\rm CC}$ =800V, $I_{\rm C}$ =3A,	-	5.2	-	
Turn-off delay time	$t_{d(off)}$	V <sub>GE</sub> =15V/0V,	-	281	-	
Fall time	t <sub>f</sub>	$R_{\rm G}$ =82 $\Omega$ ,	-	29	-	
Turn-on energy	Eon	$L_{\sigma}^{2} = 180$ nH, $C_{\sigma}^{2} = 40$ pF	-	0.14	-	mJ
Turn-off energy	E <sub>off</sub>	Energy losses include	-	0.15	-	
Total switching energy	E <sub>ts</sub>	"tail" and diode <sup>4)</sup> reverse recovery.	-	0.29	-	]

### Switching Characteristic, Inductive Load, at T<sub>i</sub>=150 °C

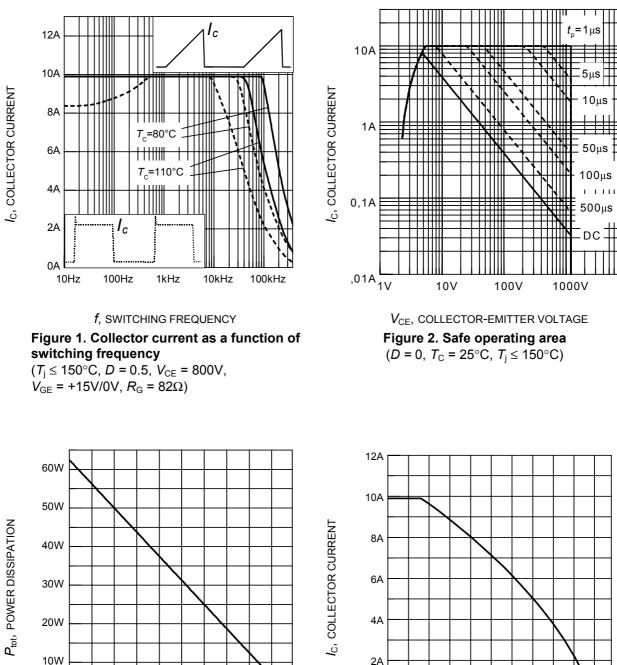
Parameter	Symbol	Conditions	Value			— Unit
Farameter	Symbol	Conditions	min.	typ.	max.	
IGBT Characteristic						
Turn-on delay time	$t_{d(on)}$	<i>T</i> <sub>j</sub> =150°C	-	9.4	-	ns
Rise time	tr	V <sub>CC</sub> =800V,	-	6.7	-	
Turn-off delay time	$t_{d(off)}$	/ <sub>C</sub> =3A,	-	340	-	
Fall time	t <sub>f</sub>	V <sub>GE</sub> =15V/0V,	-	63	-	
Turn-on energy	Eon	R <sub>G</sub> =82Ω, L <sub>σ</sub> <sup>2)</sup> =180nH,	-	0.22	-	mJ
Turn-off energy	E <sub>off</sub>	$C_{\sigma}^{2} = 180 \text{ nH},$ $C_{\sigma}^{2} = 40 \text{ pF}$	-	0.26	-	
Total switching energy	E <sub>ts</sub>	Energy losses include "tail" and diode <sup>3)</sup> reverse recovery.	-	0.48	-	

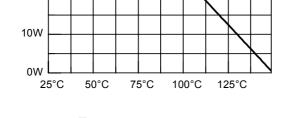
### Switching Energy ZVT, Inductive Load

Parameter	Symbol	Conditions	Value			Unit
	Symbol	Conditions	min.	typ.	max.	Onit
IGBT Characteristic		·				
Turn-off energy	E <sub>off</sub>	V <sub>CC</sub> =800V,				mJ
		/ <sub>C</sub> =3A,				
		V <sub>GE</sub> =15V/0V,				
		$R_{\rm G}$ =82 $\Omega$ ,				
		$C_{r}^{2)}=4nF$				
		<i>T</i> <sub>i</sub> =25°C	-	0.05	-	
		<i>T</i> <sub>j</sub> =150°C	-	0.09	-	

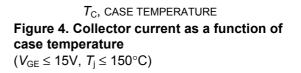
 $<sup>^{2)}</sup>$  Leakage inductance  $L_{\sigma}$  and stray capacity  $C_{\sigma}$  due to dynamic test circuit in figure E  $^{4)}$  Commutation diode from device IKP03N120H2











100°C

125°C

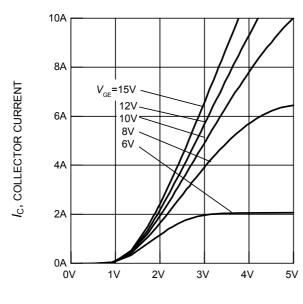
150°C

75°C

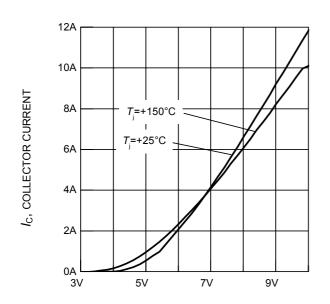
0A └─ 25°C

50°C

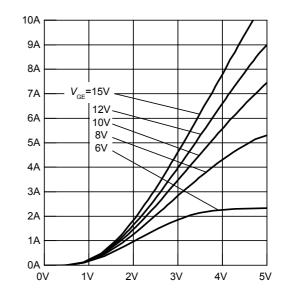




 $V_{CE}$ , COLLECTOR-EMITTER VOLTAGE Figure 5. Typical output characteristics  $(T_i = 25^{\circ}C)$ 

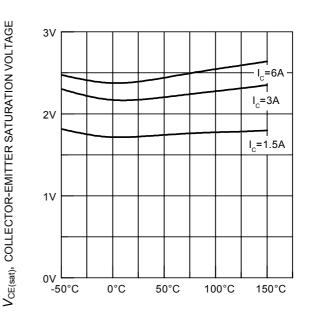


 $V_{\rm GE}$ , GATE-EMITTER VOLTAGE Figure 7. Typical transfer characteristics ( $V_{\rm CE}$  = 20V)



Ic, COLLECTOR CURRENT

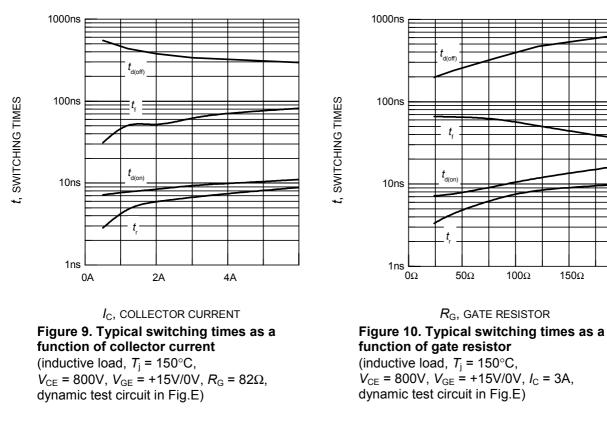
 $V_{CE}$ , COLLECTOR-EMITTER VOLTAGE Figure 6. Typical output characteristics ( $T_i = 150^{\circ}C$ )

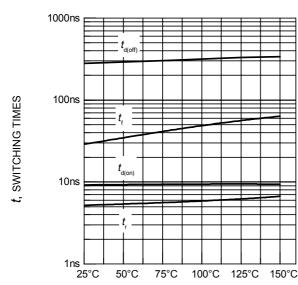


 $T_{\rm j}$ , JUNCTION TEMPERATURE Figure 8. Typical collector-emitter saturation voltage as a function of junction temperature ( $V_{\rm GE}$  = 15V)

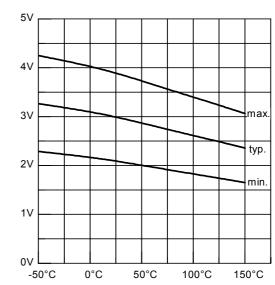
150Ω







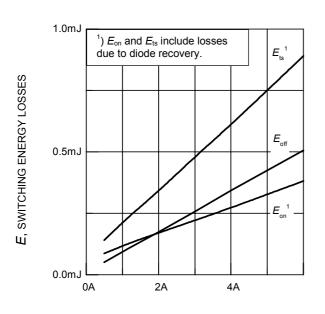
 $T_{i}$ , JUNCTION TEMPERATURE Figure 11. Typical switching times as a function of junction temperature (inductive load,  $V_{CE} = 800V$ ,  $V_{\rm GE}$  = +15V/0V,  $I_{\rm C}$  = 3A,  $R_{\rm G}$  = 82 $\Omega$ , dynamic test circuit in Fig.E)



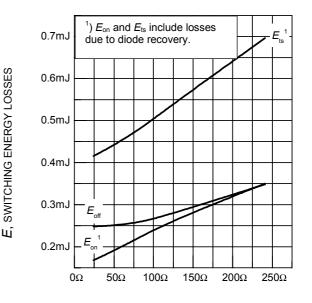
 $T_{j}$ , JUNCTION TEMPERATURE Figure 12. Gate-emitter threshold voltage as a function of junction temperature  $(I_{\rm C} = 0.09 {\rm mA})$ 

V<sub>GE(th)</sub>, GATE-EMITTER THRESHOLD VOLTAGE

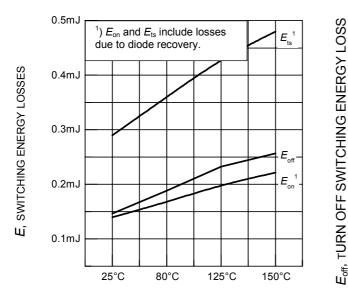




 $I_{\rm C}$ , COLLECTOR CURRENT **Figure 13. Typical switching energy losses as a function of collector current** (inductive load,  $T_{\rm j}$  = 150°C,  $V_{\rm CE}$  = 800V,  $V_{\rm GE}$  = +15V/0V,  $R_{\rm G}$  = 82 $\Omega$ , dynamic test circuit in Fig.E )



 $R_{\rm G}$ , GATE RESISTOR Figure 14. Typical switching energy losses as a function of gate resistor (inductive load,  $T_{\rm j}$  = 150°C,  $V_{\rm CE}$  = 800V,  $V_{\rm GE}$  = +15V/0V,  $I_{\rm C}$  = 3A, dynamic test circuit in Fig.E )



 $T_{j}$ , JUNCTION TEMPERATURE **Figure 15. Typical switching energy losses as a function of junction temperature** (inductive load,  $V_{CE}$  = 800V,  $V_{GE}$  = +15V/0V,  $I_{C}$  = 3A,  $R_{G}$  = 82 $\Omega$ , dynamic test circuit in Fig.E )

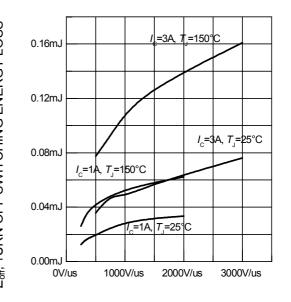




Figure 16. Typical turn off switching energy loss for soft switching (dynamic test circuit in Fig. E)



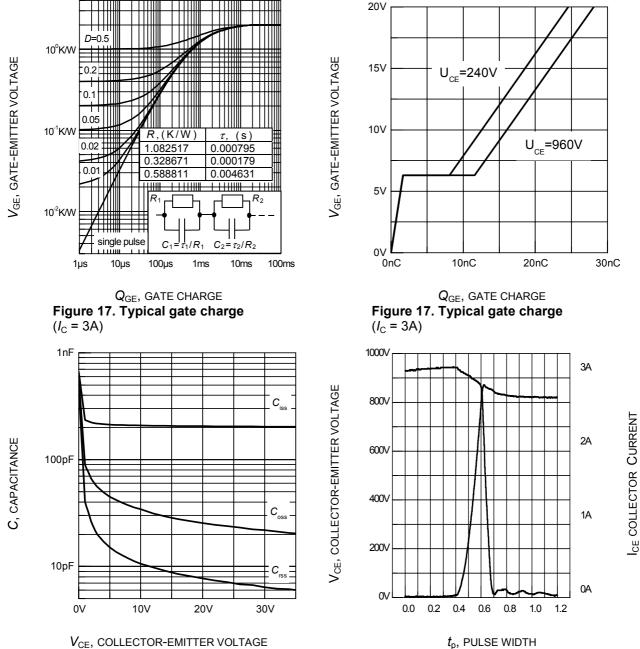
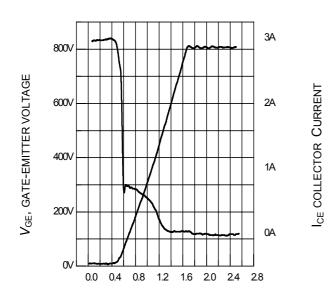


Figure 18. Typical capacitance as a function of collector-emitter voltage ( $V_{GE} = 0V, f = 1MHz$ )

Figure 20. Typical turn off behavior, hard switching

 $(V_{GE}=15/0V, R_G=82\Omega, T_j = 150^{\circ}C, Dynamic test circuit in Figure E)$ 



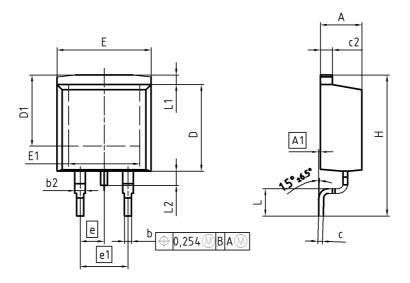


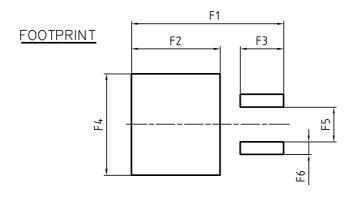
 $t_{\rm p}$ , PULSE WIDTH Figure 21. Typical turn off behavior, soft switching  $(V_{GE}=15/0V, R_G=82\Omega, T_j = 150^{\circ}C, Dynamic test circuit in Figure E)$ 

# IGB03N120H2

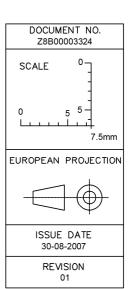


PG-TO263-3-2





DIM	MILLIME	ETERS	INCH	IES	
DIM	MIN	MAX	MIN	MAX	
А	4.30	4.57	0.169	0.180	
A1	0.00	0.25	0.000	0.010	
b	0.65	0.85	0.026	0.033	
b2	0.95	1.15	0.037	0.045	
с	0.33	0.65	0.013	0.026	
c2	1.17	1.40	0.046	0.055	
D	8.51	9.45	0.335	0.372	
D1	7.10	7.90	0.280	0.311	
E	9.80	10.31	0.386	0.406	
E1	6.50	8.60	0.256	0.339	
е	2.5	64	0.100		
e1	5.0	8	0.200		
N		2	2		
Н	14.61	15.88	0.575	0.625	
L	2.29	3.00	0.090	0.118	
L1	0.70	1.60	0.028	0.063	
L2	1.00	1.78	0.039	0.070	
F1	16.05	16.25	0.632	0.640	
F2	9.30	9.50	0.366	0.374	
F3	4.50	4.70	0.177	0.185	
F4	10.70	10.90	0.421	0.429	
F5	3.65	3.85	0.144	0.152	
F6	1.25	1.45	0.049	0.057	





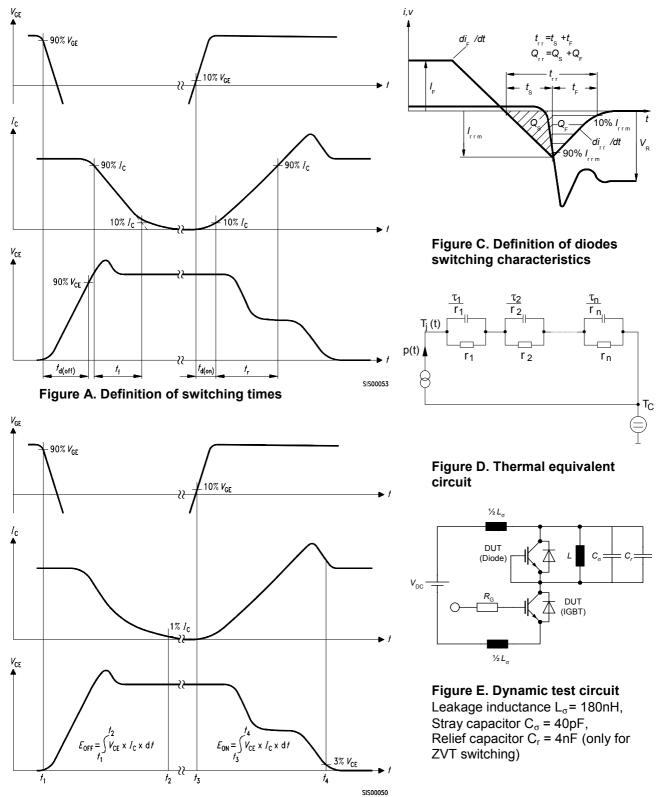


Figure B. Definition of switching losses



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